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Second edition
2018-09

Ceramic tiles —

Part 2:

Determination of dimensions and surface quality

Carreaux et dalles céramiques —

Partie 2: Détermination des caractéristiques dimensionnelles et de la qualité de surface



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Foreword

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This document was prepared by Technical Committee ISO/TC 189, *Ceramic tile*.

This second edition cancels and replaces the first edition (ISO 10545-2:1995) which has been technically revised. It also incorporates the Technical Corrigendum ISO 10545-2:1995/Cor 1:1997.

The main changes compared to the previous edition are as follows:

- for the measurement of length and width, the deviation shall be reported as a percentage and in millimetres;
- for the measurement of thickness, the deviation shall be reported as a percentage and in millimetres;
- for the measurement of straightness of sides, the deviation shall be reported as a percentage and in millimetres;
- for the measurement of the centre curvature, edge curvature and warpage, the deviation shall be reported as a percentage and in millimetres;
- tests specimens sampling has been changed;
- for rectangularity measurements of oblong tiles with longer edge ≥ 60 cm, and ratio between longer edge and shorter edge ≥ 3 , only δ_L and percent deviation shall be determined; as a consequence, the test report is modified accordingly.

A list of all parts in the ISO 10545 series can be found on the ISO website.

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